

MOSFET - P-Channel

100 V

FQD8P10TM-F085

Description

These P-Channel enhancement mode power field effect transistors are produced using **onsemi**'s proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

Features

- -6.6 A, -100 V, $R_{DS(on)} = 0.53 \Omega @ V_{GS} = -10 \text{ V}$
- Low Gate Charge (Typ. 12 nC)
- Low Crss (Typ. 30 pF)
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- Qualified to AEC-Q101
- RoHS Compliant

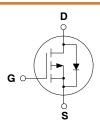
ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	-100	V
Ι _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)	-6.6 -4.2	Α
I _{DM}	Drain Current - Pulsed (Note 1)	-26.4	Α
V_{GSS}	V _{GSS} Gate-Source Voltage		V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	150	mJ
I _{AR}	I _{AR} Avalanche Current (Note 1)		Α
E _{AR}	E _{AR} Repetitive Avalanche Energy (Note 1)		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	-6.0	V/ns
P_{D}	Power Dissipation (T _A = 25°C)*	2.5	W
	Power Dissipation (T _C = 25°C) – Derate above 25°C	44 0.35	W W/°C
T _J , T _{STG}	J, T _{STG} Operating and Storage Temperature Range		°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

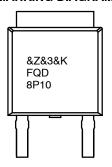
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



DPAK3 CASE 369AS



MARKING DIAGRAM



&Z = Assembly Code

&3 = Date Code (Year and Week)

&K = Lot Code

FQD8P10 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FQD8P10TM-F085	DPAK3 (Pb-Free)	2,500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Parameter		Max	Unit
Rejc	Thermal Resistance, Junction to Case		2.84	°C/W
RеJA	Thermal Resistance, Junction to Ambient*		50	°C/W
ReJA Thermal Resistance, Junction to Ambient		_	110	°C/W

NOTE:

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
OFF CHARAC	CTERISTICS					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu A$	-100	-	-	V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C	-	-0.1	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -100 V, V _{GS} = 0 V	_	-	-1	μΑ
		$V_{DS} = -80 \text{ V}, T_{C} = 125^{\circ}\text{C}$	_	-	-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	_	-	-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 30 V, V _{DS} = 0 V	-	-	100	nA
ON CHARAC	TERISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-2.0	-	-4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -3.3 \text{ A}$	_	0.41	0.53	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = -40 \text{ V}, I_D = -3.3 \text{ A (Note 4)}$	_	4.1	_	S
DYNAMIC CH	ARACTERISTICS					
C _{iss}	Input Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$	_	360	470	pF
C _{oss}	Output Capacitance	f = 1.0 MHz	-	120	155	pF
C _{rss}	Reverse Transfer Capacitance		-	30	40	pF
SWITCHING (CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -50 \text{ V}, I_D = -8.0 \text{ A},$	-	11	30	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$ (Note 4, 5)	-	110	230	ns
t _{d(off)}	Turn-Off Delay Time		-	20	50	ns
t _f	Turn-Off Fall Time		_	35	80	ns
Q_g	Total Gate Charge	$V_{DS} = -80 \text{ V}, I_D = -8.0 \text{ A},$	_	12	15	nC
Q_gs	Gate-Source Charge	V _{GS} = -10 V (Note 4, 5)	_	3.0	_	nC
Q_gd	Gate-Drain Charge	, ,	_	6.4	_	nC
DRAIN-SOUF	RCE DIODE CHARACTERISTICS AND I	MAXIMUM RATINGS				
IS	Maximum Continuous Drain-Source Diode Forward Current		_	-	-6.6	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		_	-	-26.4	Α
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -6.6 \text{ A}$	-	-	-4.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_S = -8.0 \text{ A},$	-	98	_	ns
Q _{rr}	Reverse Recovery Charge	dl _F / dt = 100 A/ μs (Note 4)	-	0.35	-	μС

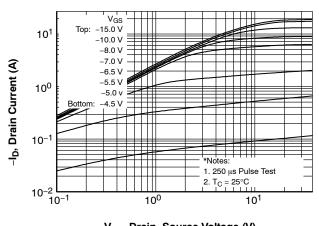
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

- 1. Repetitive Rating: Pulse–width limited by maximum junction temperature.
 2. L = 5.2 mH, I_{AS} = -6.6 A, V_{DD} = -25 V, R_{G} = 25 Ω , Starting T_{J} = 25°C.
 3. $I_{SD} \le$ -8.0 A, di/dt \le 300 A/ μ s, $V_{DD} \le$ BV $_{DSS}$, Starting T_{J} = 25°C.
 4. Pulse Test: Pulse width \le 300 μ s, Duty cycle \le 2%.
 5. Essentially independent of operating temperature.

^{*}When mounted on the minimum pad size recommended (PCB Mount)

TYPICAL CHARACTERISTICS



-V_{DS}, Drain-Source Voltage (V)

Figure 1. On-Region Characteristics

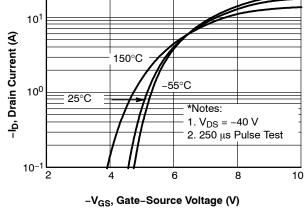


Figure 2. Transfer Characteristics

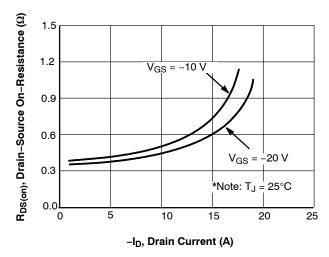


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

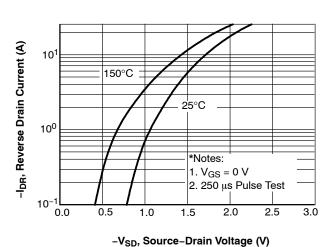


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

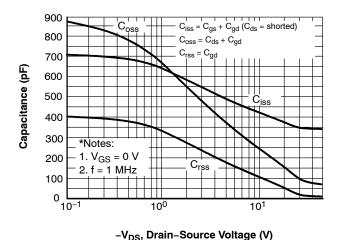


Figure 5. Capacitance Characteristics

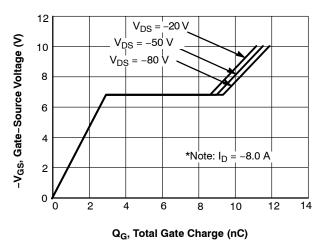
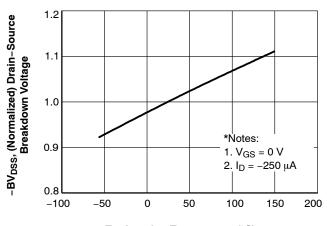


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (continue)

3.0



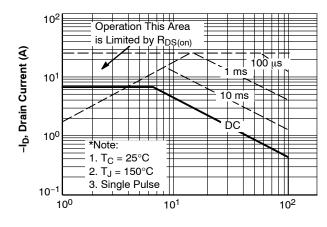
RDS(ON), (Normalized) Drain-Source 2.5 2.0 On-Resistance 1.5 1.0 *Notes: 0.5 1. $V_{GS} = -10 \text{ V}$ 2. $I_D = -3.3 \text{ A}$ 0.0 -50 200 50 100 150

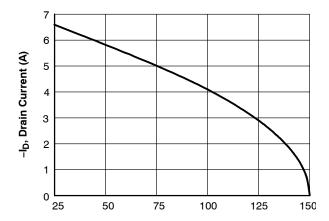
T_J, Junction Temperature (°C)

Figure 7. Breakdown Voltage Variation vs. Temperature

T_J, Junction Temperature (°C)



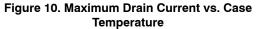


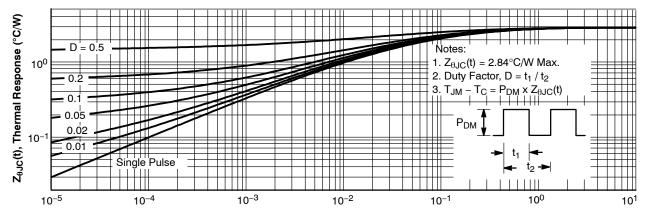


-V_{DS}, Drain-Source Voltage (V)

Figure 9. Maximum Safe Operating Area

T_C, Case Temperature (°C)





t₁, Square Wave Pulse Duration (s)

Figure 11. Transient Thermal Response Curve

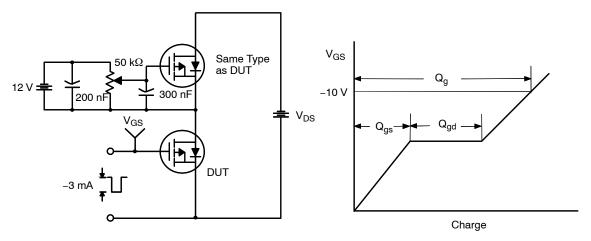


Figure 12. Gate Charge Test Circuit & Waveform

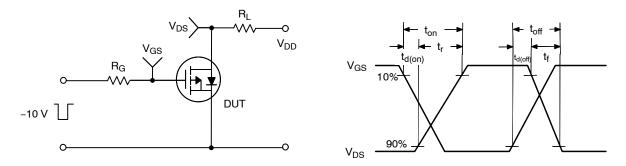


Figure 13. Resistive Switching Test Circuit & Waveforms

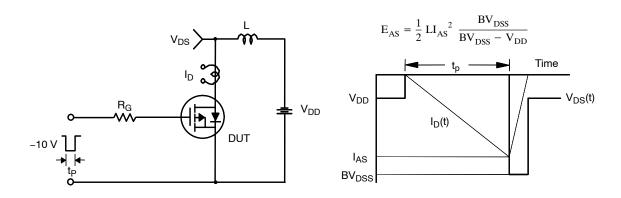
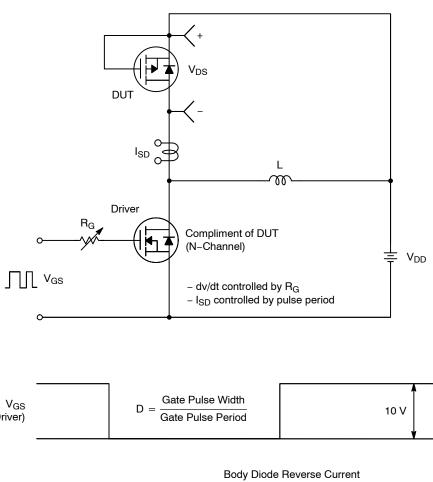
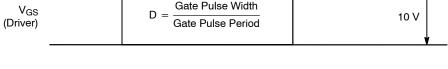
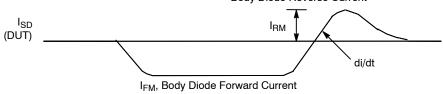


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms







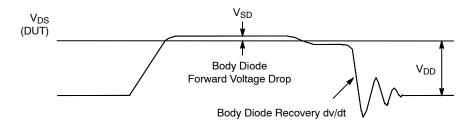


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





DPAK3 6.10x6.54x2.29, 4.57P CASE 369AS **ISSUE B**

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DATE 20 DEC 2023

- NOTES: UNLESS OTHERWISE SPECIFIED

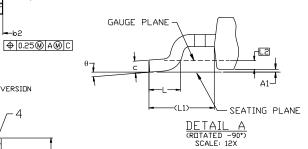
 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE F, VARIATION AA.

 B) ALL DIMENSIONS ARE IN MILLIMETERS.

 C) DIMENSIONING AND TOLERANCING PER

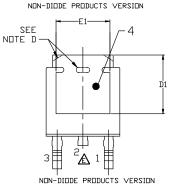
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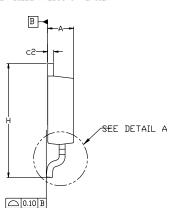
- F)
- DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-2018.
 SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
 CORNERS OR EDGE PROTRUSION.
 FOR DIGDE PRODUCTS, L4 IS 0.25 MM MAX PLASTIC BODY
 STUB WITHOUT CENTER LEAD.
 DIMENSIONS ARE EXCLUSIVE OF BURRS,
 MOLD FLASH AND TIE BAR EXTRUSIONS.
 LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD
 T0228P991X239-3N.

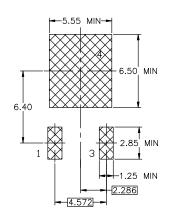


DIM	MILLIMETERS				
Din	MIN.	N□M.	MAX.		
Α	2.18	2.29	2.39		
A1	0.00	-	0.127		
b	0.64	0.77	0.89		
b2	0.76	0.95	1.14		
b3	5.21	5.34	5.46		
C	0.45	0.53	0.61		
c2	0.45	0.52	0.58		
D	5.97	6.10	6.22		
D1	5.21				
Ε	6.35	6.54	6.73		
E1	4.32				
е	2.286 BSC				
e1	4.572 BSC				
Н	9.40	9.91	10.41		
L	1.40	1.59	1.78		
L1	2.90 REF				
L2	0.51 BSC				
L3	0.89	1.08	1.27		
L4			1.02		
θ	0°		10°		

MILLIMETERS







LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON DUR
PB-FREE STRATEGY AND SOLDERING DETAILS,
PLEASE DOWNLOAD THE ON SEMICONDUCTOR
SOLDERING AND MOUNTING TECHNIQUES
REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXXXX XXXXXX **AYWWZZ**

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.

XXXX = Specific Device Code

= Assembly Location Α

Υ = Year

WW = Work Week

77 = Assembly Lot Code

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